## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | HALEY, JEFFREY T. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification		
*	Α	US-2,260,100 A	10-1941	DEITRICH EPILY C; et. al.	401/272		
*	В	US-3,777,949 A	12-1973	Chiquiari-Arias, Marcel	222/541.8		
*	С	US-4,432,749 A	02-1984	Snyder et al. 6			
*	۵	US-5,098,297 A	03-1992	Chari et al.	433/215		
*	Е	US-5,636,933 A	06-1997	Vizsolyi, Steve	401/269		
*	F	US-6,030,138 A	02-2000	Losier, Donald P.	401/266		
*	G	US-6,283,933 B1	09-2001	D'Alessio et al.	604/3		
	Η	US-					
	_	US-					
	J	US-					
	K	US-					
	L	US-					
	М	US- <sup>3</sup> -					

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0			**		
	Р				·	
	. Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	ren en e
	<b>v</b>	
	w	_
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

÷.,

÷.